Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/721,628	BAQAI ET AL.	
Examiner	Art Unit	
Wenpeng Chen	2624	

	SEARCHED			
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) - See search history printout.	6/15/06	Zur
	6/26/06	
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